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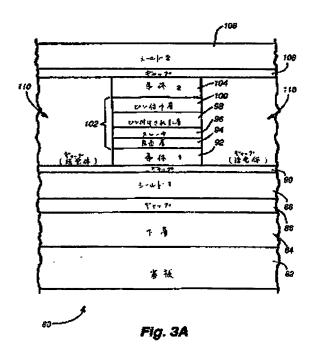
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### (54) 【発明の名称】 面垂直電流スピンパルプタイプ磁気抵抗トランスデューサ

### (57)【要約】

トランスデューサはスピンパルブ(「SV」)構造を含み、このスピンパルブ構造は、その第1の端部に近接するピン止めされた強磁性層(98)と、対向して配置された、その第2の端部に近接する自由に回転する強磁性層(94)とを含む。第1および第2の電流導体(92、104)は、面量直電流形態(「cpp」)においてそれぞれスピンパルブ構造の第1および第2の端部に近接する。ここに開示される特定的な実施例において、整動CPPトランスデューサ(120)は1対のSV構造(SV1、SV2)を含み、これらの1対のSV構造は、第1および第2の電流導体(132、152)を有し、共通の電流導体(142)がこれらのSV構造間に介在する。







## **PCT**

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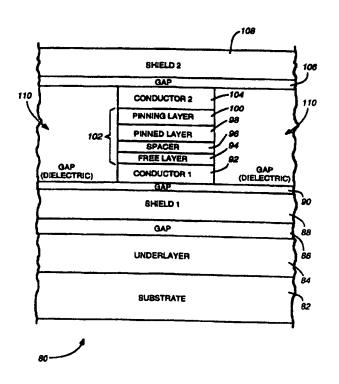
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(54) Title: CURRENT PERPENDICULAR-TO-THE-PLA	AND OF				

#### (54) Title: CURRENT PERPENDICULAR-TO-THE-PLANE SPIN VALVE TYPE MAGNETORESISTIVE TRANSDUCER

### (57) Abstract

A transducer includes a spin valve ("SV") structure comprising a pinned ferromagnetic layer (98) adjoining a first end portion thereof and a freely rotating ferromagnetic layer (94) adjoining an oppositely disposed second end portion thereof. First and second current conductors (92, 104) adjoint the first and second end portions of the spin valve structure respectively in a current perpendicular-to-the-plane configuration ("cpp"). In a particular embodiment disclosed herein, a differential CPP transducer (120) includes a pair of SV structures (SV1, SV2) having first and second current conductors (132, 152) with a common current conductor (142) intermediate the SV structures.



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# CURRENT PERPENDICULAR-TO-THE-PLANE SPIN VALVE TYPE MAGNETORESISTIVE TRANSDUCER

### CROSS REFERENCE TO RELATED APPLICATIONS

The present invention is related to the subject matter of United States Patent No. 5,485,334 for "Magnetoresistive and Method Having Improved Barkhausen Suppression" issued January 16, 1996 to J. Lamar Nix et al. and to United States Patent Application Serial No. 08/401,553 for "Shaped Spin Valve Type Magnetoresistive Transducer and Fabricating the Same Incorporating Stabilization Technique" filed March 9, 1995 by Young Keun Kim. foregoing United States Patent and Application are assigned to Quantum Peripherals Colorado, Inc., assignee of the present invention and the disclosures thereof are specifically incorporated herein bv reference.

## BACKGROUND OF THE INVENTION

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The present invention relates, in general, to the field of magnetoresistive ("MR") spin valve ("SV") devices. More particularly, the present invention relates to a current perpendicular-to-the-plane ("CPP") spin valve device design, as well as an alternative differential sensing embodiment thereof, for use, for example, as a magnetic transducer or "head" for reading data signals encoded on a magnetic mass storage medium.

Magnetoresistive devices or heads exhibiting what is referred to as giant magnetoresistance ("GMR") are of current technological interest in an attempt to achieve higher areal density recording in magnetic computer mass storage disk drives and tapes. The GMR effect was first described by M.N. Baibich, J.M. Broto, A. Fert, F. Nguyen Van Dau, F. Petroff, P. Etienne, G. Creuzet, A. Friederich and J. Chazelas in Phys. Rev. Lett. 61, 2472 (1988). Typically, the magnitude

of the magnetoresistive ratio (" $\Delta R/R$ ") for GMR materials exceeds that of anisotropic magnetoresistive ("AMR") materials, which are those generally in current use The spin valve effect is one magnetic read-transducers. known way to utilize GMR as described by B. Dieny, V.S. Speriosu, S.S.P. Parkin, B.A. Gurney, D.R. Wilhoit and D. Mauri, Phys. Rev. B 43, 1297 (1991). A typical spin valve MR device comprises two thin ferromagnetic layers (on the order of less than 100 A) separated by a nonmagnetic metal spacer (also on the order of less than 100 A). The magnetization of one ferromagnetic layer is allowed to move freely, whereas the other one is pinned by an adjacent antiferromagnetic or permanent magnetic layer. Essential to the operation of any type of GMR structure is the fact that the MR response is a function of the angle between two magnetization vectors corresponding to the sensing field.

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A number of patents have previously described various device implementations utilizing the spin valve effect. for example United States Patents No.: 5,159,513 to Dieny et al. for "Magnetoresistive Sensor Based on the Spin Valve Effect" issued October 27, 1992; 5,206,590 to Dieny et al. for "Magnetoresistive Sensor Based on the Spin Valve Effect" issued April 27, 1993; 5,287,238 to Baumgart et al. for "Dual Spin Valve Magnetoresistive Sensor" issued February 15, 1994; 5,301,079 to Cain et al. for "Current Magnetoresistive Spin Valve Sensor" issued April 5, 1994, all assigned to International Business Machines Corporation.

The stacked, orthogonal structures of the various device implementations described in these patents locate a lower ferromagnetic layer (on which the freely magnetization vector resides) above the substrate but below the upper ferromagnetic layer which has its magnetization vector pinned by an adjacent antiferromagnetic pinning layer. Moreover, in all cases the sense current is shown to flow in the plane of the layers which comprise the spin valve thereby limiting the MR response. structure, Since the current density lies within the film plane

magnetoresistive structure, this is known as a current-in-plane ("CIP") geometry.

In "A New Design for an Ultra-High Density Magnetic Recording Head Using a GMR Sensor In the CPP Rottmayer, R. and Zhu, J.; IEEE Transactions on Magnetics, Vol. 31, No. 6, November 1995 there has been proposed a GMR multilayer read element within a write head gap that operates in the current perpendicular-to-the-plane mode and is biased by an exchange coupled soft film acting like a permanent magnet while distinguishing conventional MR and SV head A multilayer read element consists of a repeated designs. layer structure which is quite different from a spin valve type GMR transducer which comprises both pinned and freely rotating ferromagnetic layers as previously described. the Moreover, Rottmayer et al. paper contemplates the placement of the multilayer sensor in the write gap of a read/write head with a soft biasing magnet exchange coupled to an antiferromagnet to bias the sensor into a linear operating range. The placement of the read sensor within the write gap is a relatively unproven configuration due to the fact that the read sensor could suffer serious degradation through repeated exposure to fields generated during write current bursts.

### 25 SUMMARY OF THE INVENTION

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In contrast, the present invention is of utility in advantageously providing a spin valve transducer, and not a multilayer GMR sensor as previously proposed, operating in a current perpendicular-to-the-plane configuration. A spin valve type GMR transducer, since it is inherently self-biased, does not require the soft biasing magnet exchange coupled to an antiferromagnet as proposed by Rottmayer et al. Moreover, the SV transducer herein disclosed is of especial utility in conjunction with the standard configuration for read/write heads wherein the write element may be placed on top of the read element without exposure to the fields generated during write current bursts.

Specifically disclosed herein is a transducer including a spin valve structure comprising a pinned ferromagnetic layer adjoining a first end portion thereof and a freely rotating ferromagnetic layer adjoining an oppositely disposed second end portion thereof. First and second current conductors adjoin the first and second end portions of the spin valve structure respectively in a current perpendicular-to-the-plane configuration.

Ιn specific embodiment disclosed herein, differential data transducer includes first and second spin valve structures each comprising a pinned ferromagnetic layer adjoining respective first end portions thereof and a freely rotating ferromagnetic layer adjoining respective oppositely disposed second end portions thereof. First and second current conductors adjoin the first and second end portions of the first and second spin valve structures respectively and a common current conductor adjoins the second and first end portions of the first and second spin valve structures respectively.

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### BRIEF DESCRIPTION OF THE DRAWINGS

The aforementioned and other features and objects of the present invention and the manner of attaining them will become more apparent and the invention itself will be best understood by reference to the following description of a preferred embodiment taken in conjunction with the accompanying drawings, wherein:

Fig. 1 is a schematic cross-sectional, air bearing surface ("ABS") view of a prior art spin valve device wherein the read track width "TW $_1$ " is defined by the metallization of the current-in-plane geometry leads overlying the pinned, upper ferromagnetic layer;

Fig. 2 is a schematic cross-sectional ABS view of a particularly advantageous spin valve device design accordance with United States Patent Application Serial No. 08/401,553 illustrating a current-in-plane configuration wherein the read track width "TW2" is defined by permanent magnet layer portions overlying the top

ferromagnetic layer and which underlying device structure may be utilized in conjunction with the current perpendicular-tothe-plane design hereinafter disclosed;

Fig 3A is a partial ABS view of a current perpendicular-to-the-plane spin valve type magnetoresistive transducer in accordance with a particular embodiment of the present invention illustrating a single spin valve structure comprising a pinning layer overlying a pinned layer, with the combination of layers, in turn, overlying a freely rotating ferromagnetic layer and the spin valve structure itself being sandwiched between a pair of current conductors and adjoining shields;

Fig. 3B is a partial side plan view of the spin valve type magnetoresistive transducer of Fig. 3A illustrating the current path through the single spin valve structure and the partially surrounding gap dielectric layer;

Fig. 4 is an additional partial side plan view of an alternative embodiment of a spin valve type magnetoresistive transducer in accordance with the present invention illustrating a pair of spin valve structures ("SV1" and "SV2") constructed in a current perpendicular-to-the-plane configuration for use as a differential signal sensor; and

Fig. 5 is a simplified, cut-away, top plan view of a conventional disk drive constituting one application of a current perpendicular-to-the plane transducer of the present invention as a magnetic "read" head.

## DESCRIPTION OF A PREFERRED EMBODIMENT

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With reference now to Fig. 1, a prior art spin valve sensor 10 structure is depicted illustrating a typical current-in-plane device configuration. The prior art spin valve sensor 10 comprises, in pertinent part, a substrate 12 having an overlying underlayer 14. The active spin valve structure itself comprises two ferromagnetic layers (formed of transition metals or alloys such as permalloy) illustrated as a lower ferromagnetic layer 16 and upper ferromagnetic layer 24 separated by a nonmagnetic spacer layer 18 (formed of a noble metal such as Cu, Ag, or Au). A pinning layer 26,

which may comprise an antiferromagnet such as FeMn, NiMn or Ni-Co oxides, is deposited on top of the upper ferromagnetic layer 24 to offer an anisotropic exchange coupling of on the order of several hundred Oersteds ("Oe"). Therefore, the direction of the magnetization of the upper ferromagnetic layer 24 is pinned with its easy axis perpendicular to the air bearing surface (ABS).

The underlayer 14 (such as Ta) and a capping layer 28 (which may also comprise Ta) are provided to protect the active structure. Permanent magnet layers 20, 22 are formed at the sides of the substantially orthogonal, stacked structure to offer domain control on the lower ferromagnetic layer 16.

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The prior art spin valve sensor 10 may also be provided in a dual configuration having two pinned ferromagnetic layers sandwiching a free ferromagnetic layer. Such a structure leads to approximately a 50% higher response than the structure shown in Fig. 1.

Nevertheless, the prior art spin valve sensor 10 and dual design both suffer from an inherent degradation of MR The MR response in a spin valve or any GMR response. material is due primarily to spin-dependent scattering of the conduction electrons. Utilizing a CIP geometry, some of the conduction electrons are prevented from experiencing spindependent scattering by shunting along layers devoid of any spin-dependent scattering centers such as the spacing layer Moreover, the design of Fig. 1 presents potential disadvantages in terms of manufacturing reproducible magnetic read head products inasmuch as a considerable amount of current density is required to deliver current to the spin valve structure through the nonmagnetic pinning and capping layers 26, all 28, of which have inherently Further, the read track width ("TW1") may not resistivities. be precisely determined because the conductor (or current lead 30, 32) layers are relatively thick compared to the active magnetic sensor structures and both the current leads 30, 32 and the permanent magnet layers 20, 22 could define the track width. This is undesirable in terms of stable read

head operation. Moreover, precise control of the thickness of the pair of permanent magnet layers 20,22 for Barkhausen noise suppression purposes is very difficult due to their limited thickness scale which is only on the order of several tens of Angstroms ("Å"). For example, when a thicker permanent magnet layer 20, 22 is needed to adjust the total magnetic moment (the remnant magnetization times thickness,  $M_x \cdot t$ ) which, in turn, determines the strength of stabilization, the permanent magnet layer 20. 22 thickness may become greater than the combined thickness of the spacer and upper ferromagnetic layers 18, 24. inherently unsatisfactory because the magnetization of the otherwise firmly pinned upper ferromagnetic layer 24 could be altered.

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With reference to Fig. 2 a shaped spin valve sensor 50 15 in accordance with the disclosure of United States Patent Application Serial No. 08/401,553 is shown. In the design of the shaped spin valve sensor 50, a substrate 52 has an overlying underlayer 54 formed thereon and a high resistivity 20 pinning layer 56 is deposited prior to any of ferromagnetic layers. Deposition of the pinning layer 56 is followed by the deposition of a thin, bottom ferromagnetic layer 58. A spacer layer 60 and a second, top ferromagnetic layer 62 are deposited next and patterned into a mesa-like structure with tapered sides. A shallow taper angle (on the 25 order of substantially 45° or less) has been found to be advantageous in order to achieve overall smoother device topography in fabrication. Thin non-magnetic separation layers 64, 66 (such as Cr) are deposited prior to the permanent magnet layers 68, 70 on the bottom ferromagnetic 30 layer 58 and the sides of the mesa (as well as a portion of the upper surface of the mesa adjoining the tapered sides) to prevent exchange coupling which could result in rotating the pinned magnetization direction of the bottom ferromagnetic The formation of current leads 72, 74 in a 35 layer 58. current-in-plane configuration follow to make directly with the permanent magnet layers 68, 70. A capping

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layer 76 overlies the current leads 72, 74, a portion of the permanent magnet layers 68, 70 and the uncovered portion of the top ferromagnetic layer 62 forming the top of the mesa structure.

In the shaped spin valve sensor 50 shown, it is the permanent magnet layers 68, 70 that define the read track width ("TW<sub>2</sub>") and not the current leads 72, 74. manner, reproducible track width control is made possible because the permanent magnet layers 68, 70 are typically thinner than the conductor layer forming the current leads thereby obviating the latters' more photolithographical challenges. Moreover, because current then be delivered directly to the active, ferromagnetic layer 62 through the permanent magnet layers 68, 70 and thin separation layers 64, 66, higher current density can be achieved than in the prior art CIP designs.

With reference additionally now to Figs. 3A and 3B, a partial ABS view of a current perpendicular-to-the-plane spin valve type magnetoresistive transducer 80 in accordance with a particular embodiment of the present invention is shown. It should be noted that the spin valve structure of Fig. 2, wherein the pinning layer 56 and pinned ferromagnetic layer 58 underlie the active ferromagnetic layer 62, may be utilized instead of the more conventional arrangement of active and pinned layers shown.

The transducer 80 comprises, in pertinent part, a substrate 82 having an overlying underlayer 84 thereupon. In turn, an insulating gap layer 86 overlies the underlayer 84. A first magnetic shield 88 overlies the gap layer 86 as shown. An optional gap layer 90, which may comprise aluminum oxide  $(Al_2O_3)$  or silicon dioxide $(SiO_2)$  may be formed upon the first magnetic shield 88. The shield layers may comprise nickel iron (NiFe), cobalt zirconium tantalum (CoZrTa), iron nitride (FeN) or other soft magnetic materials or their alloys. The shield layers may be on the order of 2 microns or less in thickness while the gap layer 90 may be between 100 and 1000 angstroms.

A first current conductor 92 is formed on top of the gap The first current conductor 92 may comprise between 100 and 1000 angstroms of rhodium (Rh), aluminum (Al), gold (Au), tantalum (Ta) or silver (Ag) or their A freely rotating ("Free" or "Active") layer 94 overlies the first current conductor 92. A non-magnetic spacer layer 96 overlies the free layer 94 and a pinned layer 98 is formed on top of the spacer layer 96. A pinning layer 100 overlies the pinned layer 98 and a second current conductor 104, of material similar to that utilized produce first current conductor 92, is formed thereon. first and second current conductors 92, 104 in conjunction with the free layer 94, spacer layer 96, pinned layer 98 and pinning layer 100 comprise a spin valve structure 102 as shown.

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In similar manner, an optional gap layer 106 overlies the second current conductor 104 followed by a second magnetic shield 108. A dielectric gap material 110 surrounds the spin valve structure 102 and portions of the first and second current conductors 92, 104 as shown.

The transducer 80, as an example only, is shown as a single spin valve structure 102 comprising a pinning layer 100 overlying a pinned layer 98, with the combination of layers, in turn, overlying a freely rotating ("free" or "active") ferromagnetic layer 94 and the spin valve structure 102 itself being sandwiched between a pair of first and second current conductors 92, 94 and adjoining first and second magnetic shields 88, 108.

With reference specifically to Fig. 3B the current path through the single spin valve structure 102 is shown in addition to the partially surrounding gap dielectric material 110. Utilizing a CPP geometry for the transducer 80 forces the current to traverse each layer of the spin valve structure 102 thereby preventing shunting currents which would otherwise reduce spin-dependent scattering and, hence, the magnetoresistive response. In this manner a CPP geometry transducer 80 will display a higher magnetoresistive response than a comparable CIP device. Although not illustrated, a

permanent magnet may be added to the structure of the transducer 80 to provide domain control and, in some applications, the conductors 92, 104 might be eliminated and the shields 88, 108 instead utilized as the transducer 80 conduction paths.

It should also be noted that the spin valve structure 102 may be substantially as illustrated or, in an alternative embodiment, the spin valve structure of Fig. 2 might be substituted therefor. Moreover, the spin valve structure 102 may instead be a dual-spin valve type device comprising two or more spin-valves separated by a relatively thick conductor spacing layer. With proper orientation of the respective pinning layers of a dual-spin valve device, two spin-valves in series could function analogously to a dual-stripe AMR magnetoresistive sensor.

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With reference additionally now to Fig. 4, an alternative embodiment of a spin valve transducer 120 is shown which may be utilized as a differential read head. The transducer 120 includes a substrate 122 and overlying underlayer 124, an overlying gap layer 126 and a first magnetic shield 128. As with the preceding embodiment of Figs. 3A & 3B, an optional gap layer 130 may be provided on top of the first magnetic shield 128.

Similarly, first spin valve structure comprises a first current conductor 132, a free layer 134, a spacer layer 136, a pinned layer 138 and a pinning layer 140. A common current conductor ("Conductor C") 142 overlies the pinning layer of the first spin valve structure SV1. structure of a second spin valve structure ("SV2") comprising a free layer 144, a spacer layer 146, a pinned layer 148 and a pinning layer 150 is formed on the common conductor 142. A second current conductor 152 is formed on top of the pinning layer 150 of the second spin valve structure SV2. manner, an optional gap layer 154 may be formed on top of the second current conductor 152 followed by a second magnetic shield 156.

A CPP spin-valve transducer as described and illustrated with respect to the foregoing Figs. 3A, 3B and 4 is also

simpler to manufacture and process than a conventional CIP design since the former is inherently planar thereby easing photolithographic processing operations. Moreover, a CPP spin-valve transducer as hereinbefore disclosed may be manufactured utilizing fewer processing steps.

With reference additionally now to Fig. 5, a simplified, cut-away, top plan view of a disk drive 170 is shown for possible use in conjunction with the current perpendicularto-the-plane transducer of the present invention. drive 170 comprises, in pertinent part, a number of disks 172 which are rotated about a central axis. A read/write head 174, which may include an a transducer in accordance with the present invention as a "read" element, is positioned by means of a positioner 176 with respect to a number of concentric data tracks on the surfaces 178 of the disks 172 to enable data to be written to, or read from, the magnetically hard surfaces 178 thereof. The transducer hereinbefore disclosed may also be utilized in conjunction with tape drives and other computer mass storage applications as well.

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The CPP spin-valve transducer disclosed, therefore, is superior to conventional CIP designs in that it provides an enhanced  $\Delta R/R$  response (which is on the order of a two-fold increase over conventional CIP geometries), more planar processing and a reduced number of fabrication steps.

While there have been described above the principles of the present invention in conjunction with specific device structure and fabrication techniques, it is to be clearly understood that the foregoing description is made only by way of example and not as a limitation to the scope of the invention. Particularly, it is recognized that the teachings of the foregoing disclosure will suggest other modifications those persons skilled in the relevant art. modifications may involve other features which are already known per se and which may be used instead of or in addition to features already described herein. Although claims have formulated in this application to combinations of features, it should be understood that the

scope of the disclosure herein also includes any novel feature or any novel combination of features disclosed either explicitly or implicitly or any generalization modification thereof which would be apparent to persons skilled in the relevant art, whether or not such relates to the same invention as presently claimed in any claim and whether or not it mitigates any or all of the same technical problems as confronted by the present invention. applicants hereby reserve the right to formulate new claims to such features and/or combinations of such features during the prosecution of the present application or of any further application derived therefrom.

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### CLAIMS

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A transducer comprising:

a spin valve structure comprising a pinned ferromagnetic layer adjoining a first end portion thereof and a freely rotating ferromagnetic layer adjoining an oppositely disposed second end portion thereof; and

first and second current conductors adjoining said first and second end portions of said spin valve structure respectively.

- 2. The transducer of claim 1 further comprising a pinning layer overlying said pinned layer at said first end portion of said spin valve structure.
- 3. The transducer of claim 1 further comprising a spacer layer intermediate said pinned and freely rotating magnetic layers.
- 4. The transducer of claim 1 further comprising first and second generally parallel and spaced apart magnetic shields disposed laterally of said first and second current conductors.
- 5. The transducer of claim 4 further comprising first and second gap layers disposed intermediate said first and second current conductors and said first and second magnetic shields.
  - 6. The transducer of claim 4 further comprising a substrate and overlying underlayer disposed laterally of a selected one of said first and second magnetic shields.
  - 7. The transducer of claim 6 further comprising an intermediate gap layer interposed between said underlayer and said selected one of said first and second magnetic shields.
- 8. The transducer of claim 1 wherein said pinned and freely rotating ferromagnetic layers comprise a transition metal.
  - 9. The transducer of claim 8 wherein said transition metal comprises permalloy.
  - 10. The transducer of claim 1 wherein said pinned and freely rotating ferromagnetic layers are substantially between 20-200 A thick.

11. The transducer of claim 10 wherein said pinned and freely rotating ferromagnetic layers are substantially 100 A thick.

12. The transducer of claim 2 wherein said pinning layer comprises an exchange coupled antiferromagnet.

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- 13. The transducer of claim 12 wherein said exchange coupled antiferromagnet is selected from a group comprising FeMN, NiMn, NiO and NiCoO.
- 14. The transducer of claim 2 wherein said pinning layer 5 comprises a permanent magnet layer.
  - 15. The transducer of claim 14 wherein said permanent magnet layer is selected from a group comprising Cr and its alloys.
  - 16. The transducer of claim 14 wherein said permanent magnet layer is substantially between 50-500 A thick.
- 50 17. The transducer of claim 3 wherein said spacer layer comprises a non-magnetic material.
  - 18. The transducer of claim 17 wherein said non-magnetic material comprises a noble metal.
- 19. The transducer of claim 3 wherein said spacer layer is substantially between 10-50 A thick.
  - 20. The transducer of claim 6 wherein said underlayer is selected from a group comprising Ta and oxides of Al and Si.
  - 21. The transducer of claim 1 further comprising a dielectric substantially surrounding said spin valve
- 60 structure medially of said first and second current conductors.
  - 22. The transducer of claim 1 wherein said first and second current conductors are selected from a group comprising Rh, Al, Au, Ta, Ag and their alloys.
- 65 23. The transducer of claim 22 wherein said first and second current conductors are substantially between 100-1000 A in thickness.
  - 24. The transducer of claim 4 wherein said first and second magnetic shields comprise a relatively soft magnetic material.
  - 25. The transducer of claim 24 wherein said relatively soft magnetic material is selected from a group comprising permalloy, NiFe, CoZrTa and their alloys.

26. The transducer of claim 4 wherein said first and second magnetic shields are substantially 2μ or less in thickness.

- 27. The transducer of claim 5 wherein said first and second gap layers are selected from a group comprising  $Al_2O_3$  and  $SiO_2$ .
- 28. The transducer of claim 27 wherein said first and second gap layers are substantially between 100-1000 A in thickness.
  - 29. The transducer of claim 1 further comprising:
    - a head disk assembly;

at least one magnetic storage media rotatably contained within said head disk assembly having data encodable thereon; and

at least one positioner mechanism movably contained within said head disk assembly for positioning said transducer with respect to said storage media to enable reading of selected portions of said data.

90 30. A transducer comprising:

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first and second spin valve structures each comprising a pinned ferromagnetic layer adjoining respective first end portions thereof and a freely rotating ferromagnetic layer adjoining respective oppositely disposed second end portions thereof;

first and second current conductors adjoining said first and second end portions of said first and second spin valve structures respectively; and

- a common current conductor adjoining said second and 100 first end portions of said first and second spin valve structures respectively.
  - 31. The transducer of claim 30 further comprising a pinning layer overlying said pinned layer at said first end portions of said first and second spin valve structures.
- 105 32. The transducer of claim 30 further comprising a spacer layer intermediate said pinned and freely rotating magnetic layers of said first and second spin valve structures.
  - 33. The transducer of claim 30 further comprising first and second generally parallel and spaced apart magnetic shields
- 110 disposed laterally of said first and second current conductors.

34. The transducer of claim 33 further comprising first and second gap layers disposed intermediate said first and second current conductors and said first and second magnetic shields.

- 35. The transducer of claim 33 further comprising a substrate and overlying underlayer disposed laterally of a selected one of said first and second magnetic shields.
- 36. The transducer of claim 35 further comprising an
- intermediate gap layer interposed between said underlayer and said selected one of said first and second magnetic shields.

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- 37. The transducer of claim 30 wherein said pinned and freely rotating ferromagnetic layers of said first and second spin valve structures comprise a transition metal.
- 125 38. The transducer of claim 37 wherein said transition metal comprises permalloy.
  - 39. The transducer of claim 30 wherein said pinned and freely rotating ferromagnetic layers of said first and second spin valve structures are substantially between 20-200 A thick.
  - 40. The transducer of claim 39 wherein said pinned and freely rotating ferromagnetic layers are substantially 100 A thick.
- 41. The transducer of claim 31 wherein said pinning layer comprises an exchange coupled antiferromagnet.
  - 42. The transducer of claim 41 wherein said exchange coupled antiferromagnet is selected from a group comprising FeMN, NiMn, NiO and NiCoO.
- 43. The transducer of claim 31 wherein said pinning layer comprises a permanent magnet layer.
  - 44. The transducer of claim 43 wherein said permanent magnet layer is selected from a group comprising Cr and its alloys.
  - 45. The transducer of claim 44 wherein said permanent magnet layer is substantially between 50-500 A thick.
- 145 46. The transducer of claim 32 wherein said spacer layer comprises a non-magnetic material.
  - 47. The transducer of claim 46 wherein said non-magnetic material comprises a noble metal.

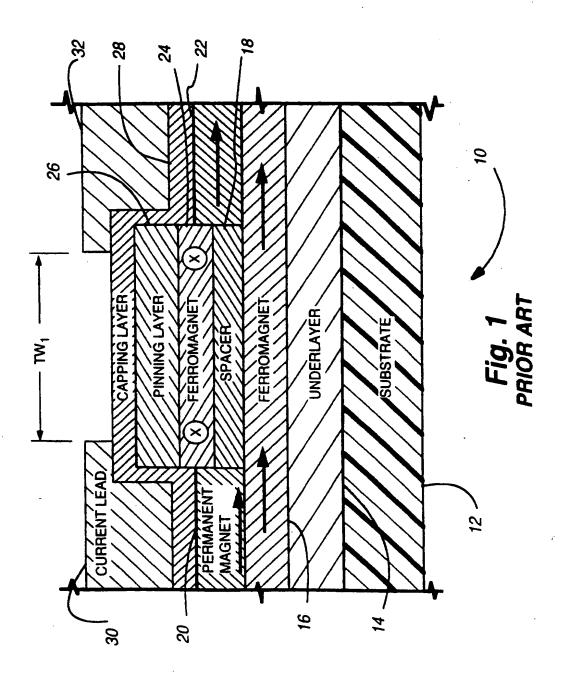
48. The transducer of claim 32 wherein said spacer layer is substantially between 10-50 A thick.

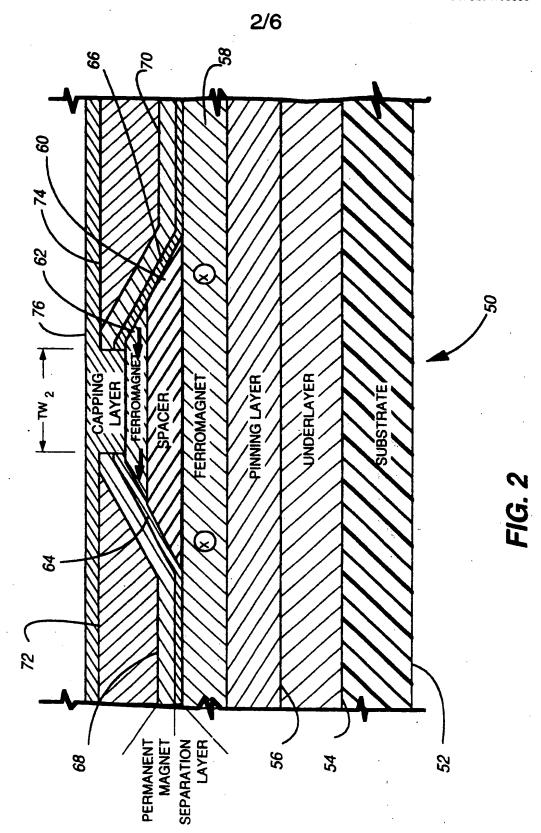
- 49. The transducer of claim 35 wherein said underlayer is selected from a group comprising Ta and oxides of Al and Si.
- 50. The transducer of claim 30 further comprising a dielectric substantially surrounding said first and second
- spin valve structures medially of said first and second current conductors and said common current conductor.
  - 51. The transducer of claim 30 wherein said first, second and common current conductors are selected from a group comprising Rh, Al, Au, Ta, Ag and their alloys.
- 160 52. The transducer of claim 51 wherein said first, second and common current conductors are substantially between 100-1000 A in thickness.
  - 53. The transducer of claim 33 wherein said first and second magnetic shields comprise a relatively soft magnetic material.
  - 54. The transducer of claim 53 wherein said relatively soft magnetic material is selected from a group comprising permalloy, NiFe, CoZrTa and their alloys.
- 55. The transducer of claim 33 wherein said first and second magnetic shields are substantially 2µ or less in thickness.
  - 56. The transducer of claim 34 wherein said first and second gap layers are selected from a group comprising  $\mathrm{Al}_2\mathrm{O}_3$  and  $\mathrm{SiO}_2$ .
- 57. The transducer of claim 56 wherein said first and second gap layers are substantially between 100-1000 A in thickness.

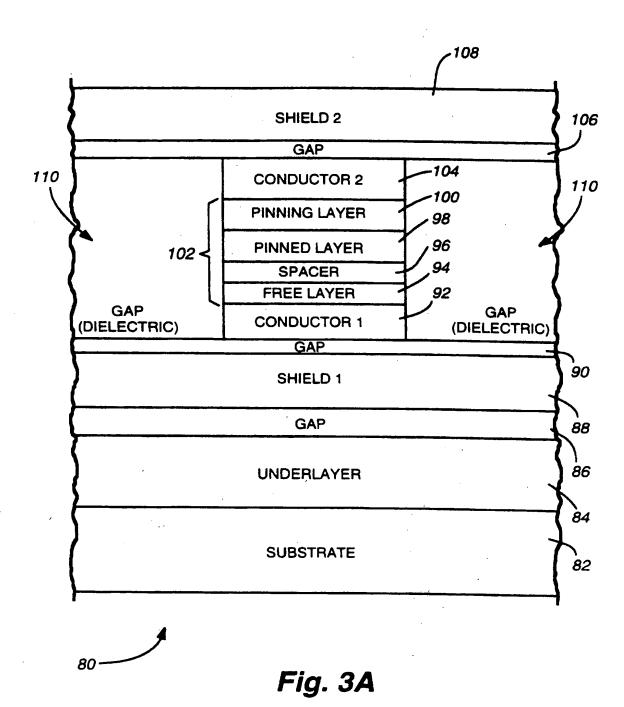
  58. The transducer of claim 30 further comprising:
  - a head disk assembly;

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- at least one magnetic storage media rotatably contained within said head disk assembly having data encodable thereon; and
  - at least one positioner mechanism movably contained within said head disk assembly for positioning said transducer with respect to said storage media to enable reading of selected portions of said data.







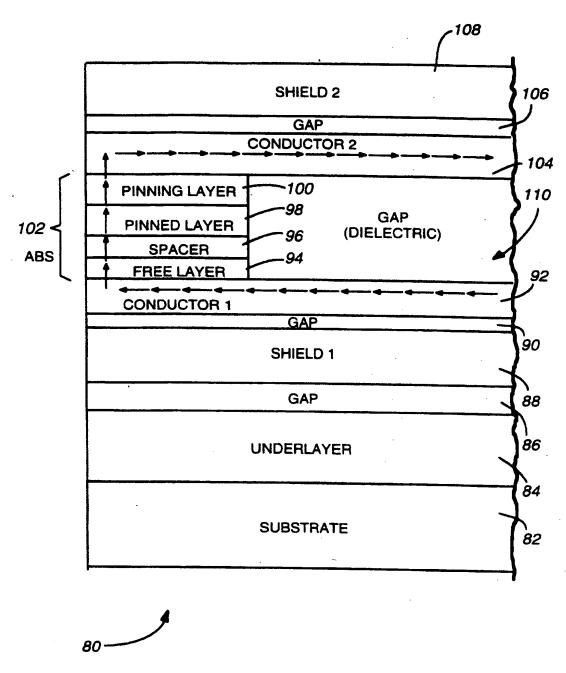
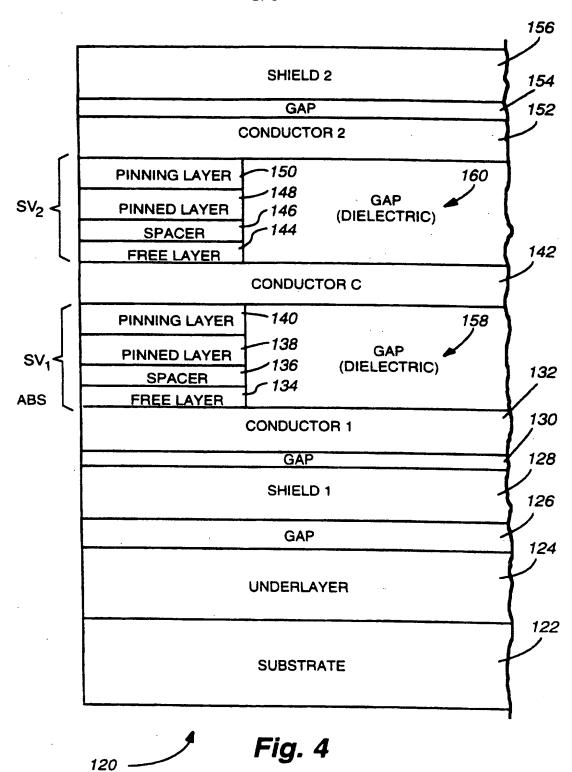
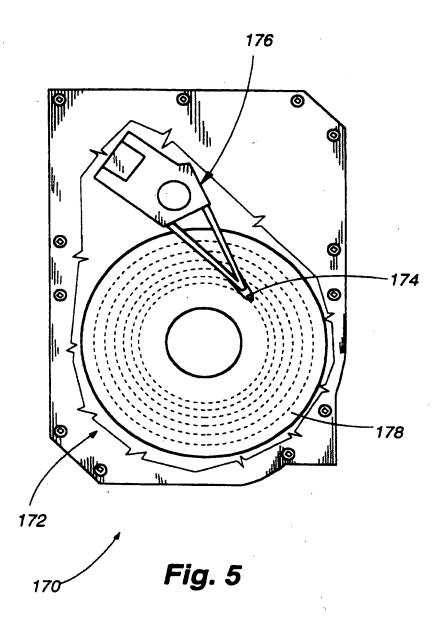


Fig. 3B





## INTERNATIONAL SEARCH REPORT

International application No. PCT/US97/08601

A. CLASSIFICATION OF SUBJECT MATTER								
IPC(6) :G 11 B 5/39 US CL :360/113								
According to International Patent Classification (IPC) or to both national classification and IPC								
B. FIELDS SEARCHED								
Minimum documentation searched (classification system follow	ved by classification symbols)							
U.S. : 360/113, 126								
Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched								
Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)								
`								
C. DOCUMENTS CONSIDERED TO BE RELEVANT								
Category* Citation of document, with indication, where	appropriate, of the relevant passages Relevant to claim No.							
X US 5,390,061 A (NAKATANI E (14/2/95), SEE ENTIRE DOCUME	T AL) 14 FEBRUARY 1995 1-58							
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Further documents are listed in the continuation of Box	C. See patent family annex.							
"A" document defining the general state of the art which is not considered	T later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory understand.							
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"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citized to establish the publication date of another citizens.	'X' document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken abone							
*O* document referring to an oral disclosure, use, exhibition or other means	document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more than the document is							
*P* document published prior to the international filing date but later than the priority date claimed	being obvious to a person skilled in the art  '&' document member of the same patent family							
Date of the actual completion of the international search	Date of mailing of the international search report							
28 AUGUST 1997	1 1 SEP 1997							
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Washington, D.C. 20231	A.1. HEINZ							
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